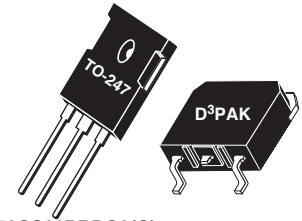


Thunderbolt® High Speed NPT IGBT with Anti-Parallel 'DQ' Diode

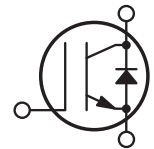
The Thunderbolt HS™ series is based on thin wafer non-punch through (NPT) technology similar to the Thunderbolt® series, but trades higher $V_{CE(ON)}$ for significantly lower turn-on energy E_{off} . The low switching losses enable operation at switching frequencies over 100kHz, approaching power MOSFET performance but lower cost.

An extremely tight parameter distribution combined with a positive $V_{CE(ON)}$ temperature coefficient make it easy to parallel Thunderbolts HS™ IGBT's. Controlled slew rates result in very good noise and oscillation immunity and low EMI. The short circuit duration rating of 10 μ s make these IGBT's suitable for motor drive and inverter applications. Reliability is further enhanced by avalanche energy ruggedness. Combi versions are packaged with a high speed, soft recovery DQ series diode.




APT50GS60BRDQ2(G)
APT50GS60SRDQ2(G)

Single die IGBT with separate DQ diode die



Features

- Fast Switching with low EMI
- Very Low E_{OFF} for Maximum Efficiency
- Short circuit rated
- Low Gate Charge
- Tight parameter distribution
- Easy paralleling
- RoHS Compliant 

Typical Applications

- ZVS Phase Shifted and other Full Bridge
- Half Bridge
- High Power PFC Boost
- Welding
- Induction heating
- High Frequency SMPS

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
I_{C1}	Continuous Collector Current $T_C = @ 25^\circ C$	93	A	
I_{C1}	Continuous Collector Current $T_C = @ 100^\circ C$	50		
I_{CM}	Pulsed Collector Current ^①	195		
V_{GE}	Gate-Emitter Voltage	$\pm 30V$	V	
SSOA	Switching Safe Operating Area	195		
E_{AS}	Single Pulse Avalanche Energy ^②	280	mJ	
t_{SC}	Short Circuit Withstand Time ^③	10	μ s	
I_F	Diode Continuous Forward Current	$T_C = 25^\circ C$	90	A
		$T_C = 100^\circ C$	55	
I_{FRM}	Diode Max. Repetitive Forward Current	195		

Thermal and Mechanical Characteristics

Symbol	Parameter	Min	Typ	Max	Unit
P_D	Total Power Dissipation $T_C = @ 25^\circ C$	-	-	415	W
$R_{\theta JC}$	Junction to Case Thermal Resistance	IGBT	-	0.30	$^\circ C/W$
		Diode	-	0.67	
$R_{\theta CS}$	Case to Sink Thermal Resistance, Flat Greased Surface	-	0.11	-	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55	-	150	$^\circ C$
T_L	Soldering Temperature for 10 Seconds (1.6mm from case)	-	-	300	
W_T	Package Weight	-	0.22	-	oz
		-	5.9	-	g
Torque	Mounting Torque (TO-247), 6-32 M3 Screw	-	-	10	in-lbf
		-	-	1.1	N·m

 **CAUTION:** These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should be Followed.

Microsemi Website - <http://www.microsemi.com>

Static Characteristics
 $T_J = 25^\circ\text{C}$ unless otherwise specified
APT50GS60B_SRDQ2(G)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit	
$V_{BR(CES)}$	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_C = 250\mu A$	600	-	-	V	
$\Delta V_{BR(CES)}/\Delta T_J$	Breakdown Voltage Temperature Coeff	Reference to $25^\circ\text{C}, I_C = 250\mu A$	-	0.60	-	V/ $^\circ\text{C}$	
$V_{CE(ON)}$	Collector-Emitter On Voltage ^④	$V_{GE} = 15V$ $I_C = 50A$	$T_J = 25^\circ\text{C}$	-	2.8	3.15	V
			$T_J = 125^\circ\text{C}$	-	3.25	-	
V_{EC}	Diode Forward Voltage ^④	$I_C = 50A$	$T_J = 25^\circ\text{C}$	-	2.15	-	
			$T_J = 125^\circ\text{C}$	-	1.8	-	
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1mA$	3	4	5	mV/ $^\circ\text{C}$	
$\Delta V_{GE(th)}/\Delta T_J$	Threshold Voltage Temp Coeff		-	6.7	-		
I_{CES}	Zero Gate Voltage Collector Current	$V_{CE} = 600V,$ $V_{GE} = 0V$	$T_J = 25^\circ\text{C}$	-	-	50	μA
			$T_J = 125^\circ\text{C}$	-	-	TBD	
I_{GES}	Gate-Emitter Leakage Current	$V_{GE} = \pm 20V$	-	-	± 100	nA	

Dynamic Characteristics
 $T_J = 25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
g_{fs}	Forward Transconductance	$V_{CE} = 50V, I_C = 50A$	-	31	-	S
C_{ies}	Input Capacitance	$V_{GE} = 0V, V_{CE} = 25V$ $f = 1MHz$	-	2635	-	pF
C_{oes}	Output Capacitance		-	240	-	
C_{res}	Reverse Transfer Capacitance		-	145	-	
$C_{o(cr)}$	Reverse Transfer Capacitance Charge Related ^⑤	$V_{GE} = 0V$ $V_{CE} = 0$ to $400V$	-	115	-	
$C_{o(er)}$	Reverse Transfer Capacitance Current Related ^⑥		-	85	-	
Q_g	Total Gate Charge	$V_{GE} = 0$ to $15V$ $I_C = 50A, V_{CE} = 300V$	-	235	-	nC
Q_{ge}	Gate-Emitter Charge		-	18	-	
Q_{gc}	Gate-Collector Charge		-	100	-	
$t_{d(on)}$	Turn-On Delay Time	Inductive Switching IGBT and Diode: $T_J = 25^\circ\text{C}, V_{CC} = 400V,$ $I_C = 50A$ $R_G = 4.7\Omega$ ^⑦ , $V_{GG} = 15V$	-	16	-	ns
t_r	Rise Time		-	33	-	
$t_{d(off)}$	Turn-Off Delay Time		-	225	-	
t_f	Fall Time		-	37	-	
E_{on1}	Turn-On Switching Energy ^⑧		-	TBD	-	
E_{on2}	Turn-On Switching Energy ^⑨	Inductive Switching IGBT and Diode: $T_J = 125^\circ\text{C}, V_{CC} = 400V,$ $I_C = 50A$ $R_G = 4.7\Omega$ ^⑦ , $V_{GG} = 15V$	-	1.2	-	mJ
E_{off}	Turn-Off Switching Energy ^⑩		-	0.755	-	
$t_{d(on)}$	Turn-On Delay Time		-	33	-	
t_r	Rise Time	-	33	-	ns	
$t_{d(off)}$	Turn-Off Delay Time	-	250	-		
t_f	Fall Time	-	23	-		
E_{on1}	Turn-On Switching Energy ^⑧	Inductive Switching IGBT and Diode: $T_J = 125^\circ\text{C}, V_{CC} = 400V,$ $I_C = 50A$ $R_G = 4.7\Omega$ ^⑦ , $V_{GG} = 15V$	-	TBD	-	mJ
E_{on2}	Turn-On Switching Energy ^⑨		-	1.7	-	
E_{off}	Turn-Off Switching Energy ^⑩		-	0.950	-	
t_{rr}	Diode Reverse Recovery Time	$I_F = 50A$ $V_R = 400V$ $di_F/dt = 200A/\mu s$	-	25	-	ns
Q_{rr}	Diode Reverse Recovery Charge		-	35	-	nC
I_{rrm}	Peak Reverse Recovery Current		-	3	-	A

TYPICAL PERFORMANCE CURVES

APT50GS60B_SRDQ2(G)

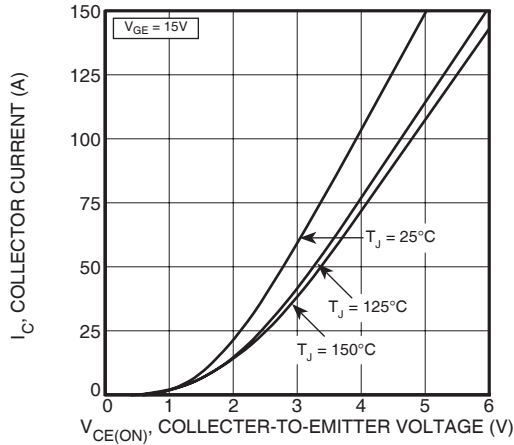


FIGURE 1, Output Characteristics

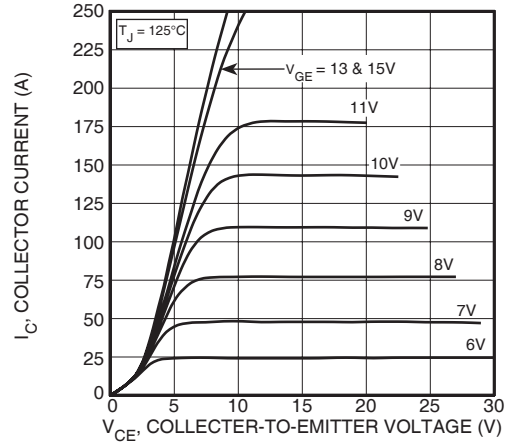


FIGURE 2, Output Characteristics

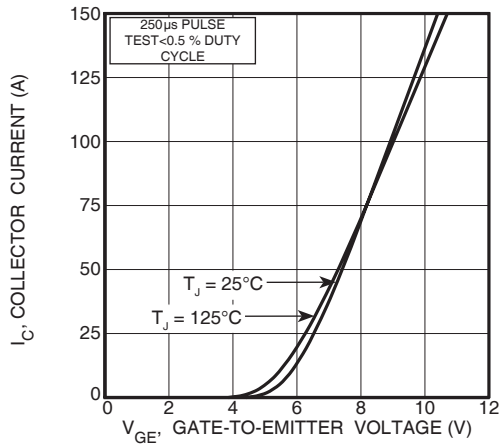


FIGURE 3, Transfer Characteristics

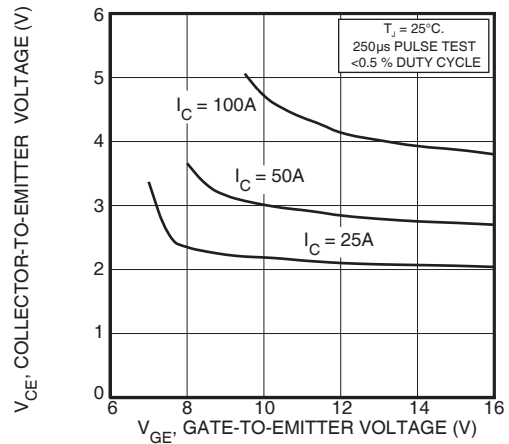


FIGURE 4, On State Voltage vs Gate-to-Emitter Voltage

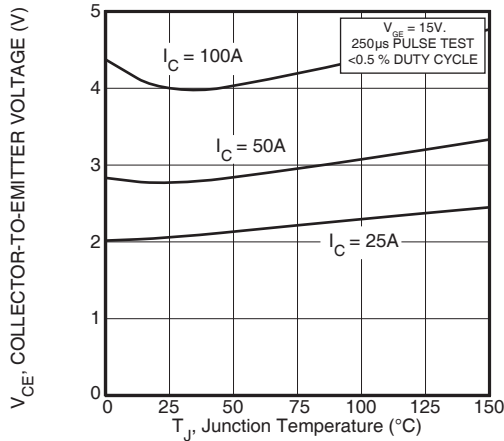


FIGURE 5, On State Voltage vs Junction Temperature

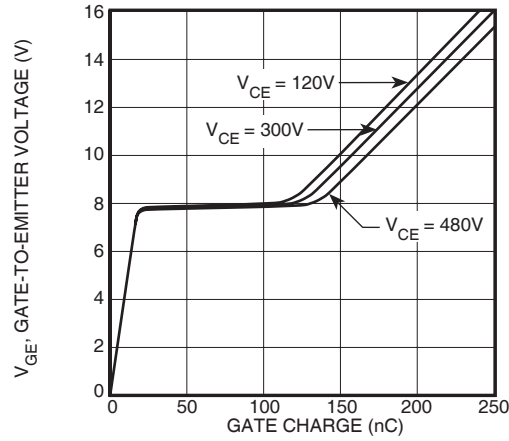


FIGURE 6, Gate Charge

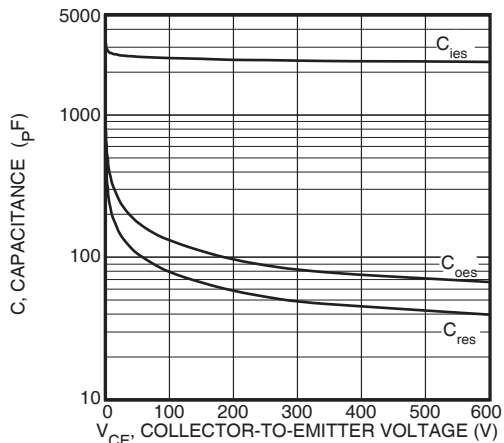


FIGURE 7, Capacitance vs Collector-To-Emitter Voltage

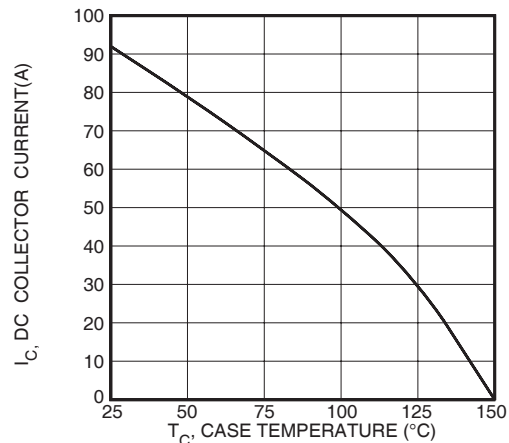


FIGURE 8, DC Collector Current vs Case Temperature

$I_C = 25A$
 $T_J = 25^\circ C$

TYPICAL PERFORMANCE CURVES

APT50GS60B_SRDQ2(G)

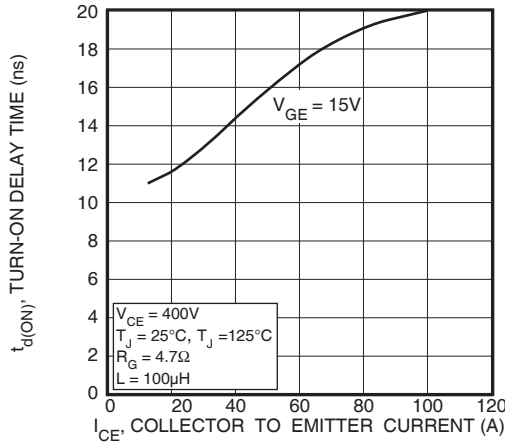


FIGURE 9, Turn-On Delay Time vs Collector Current

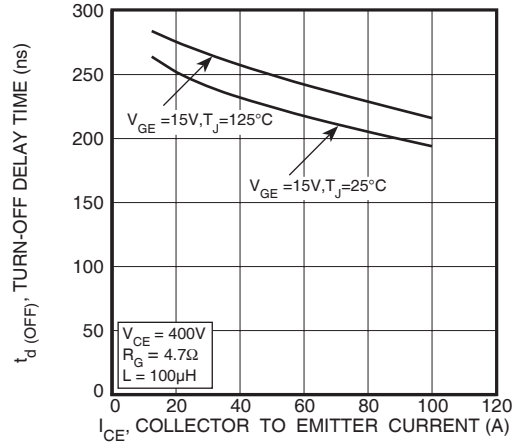


FIGURE 10, Turn-Off Delay Time vs Collector Current

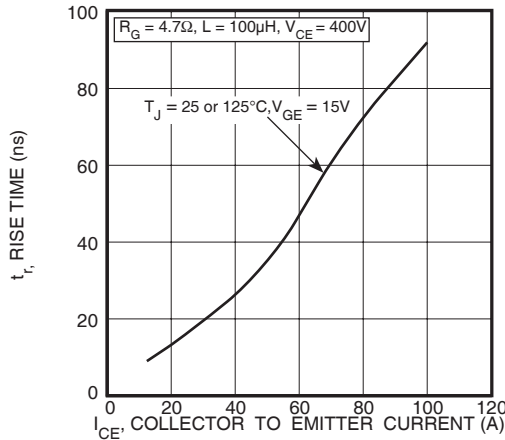


FIGURE 11, Current Rise Time vs Collector Current

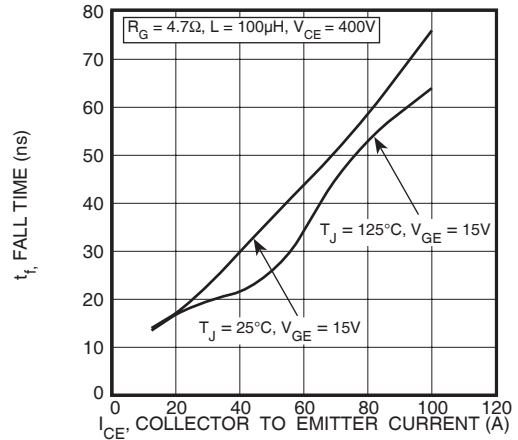


FIGURE 12, Current Fall Time vs Collector Current

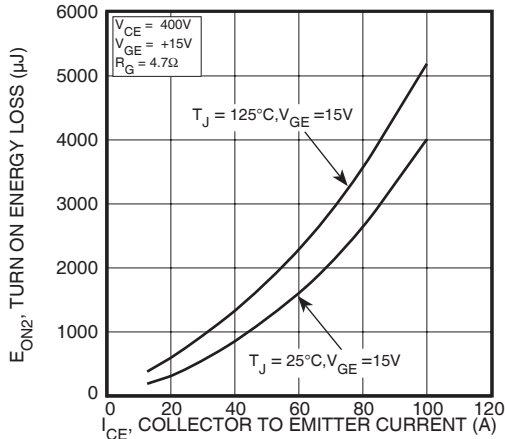


FIGURE 13, Turn-On Energy Loss vs Collector Current

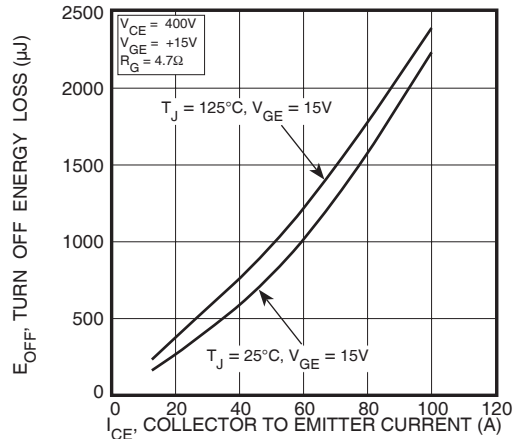


FIGURE 14, Turn Off Energy Loss vs Collector Current

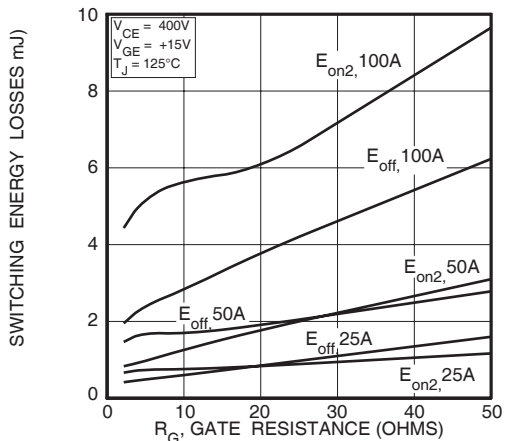


FIGURE 15, Switching Energy Losses vs. Gate Resistance

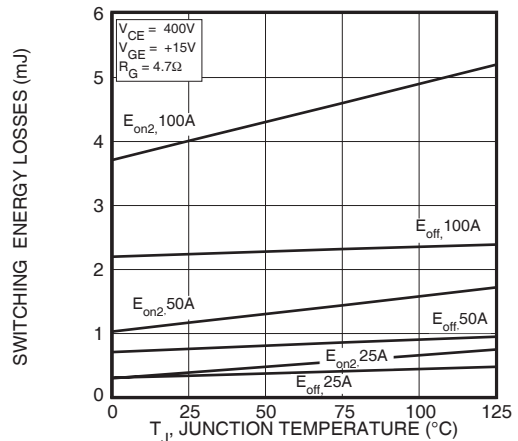
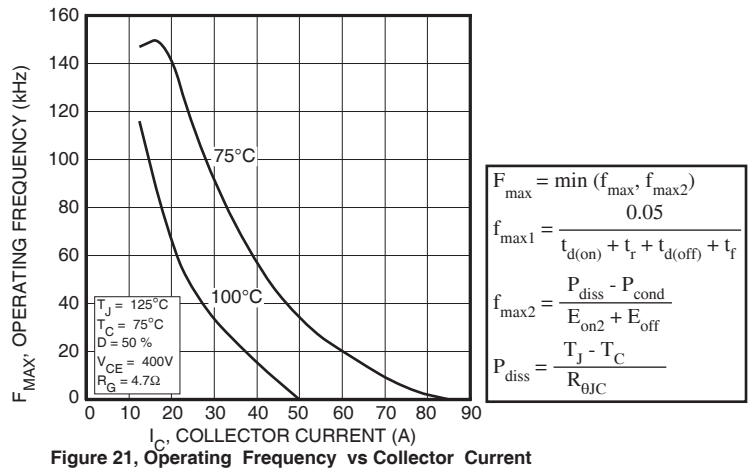
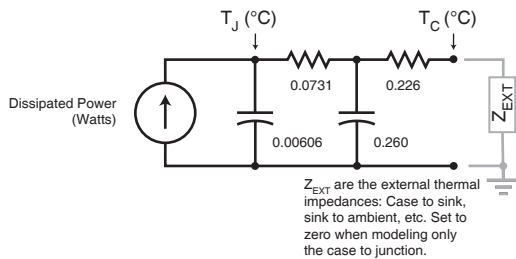
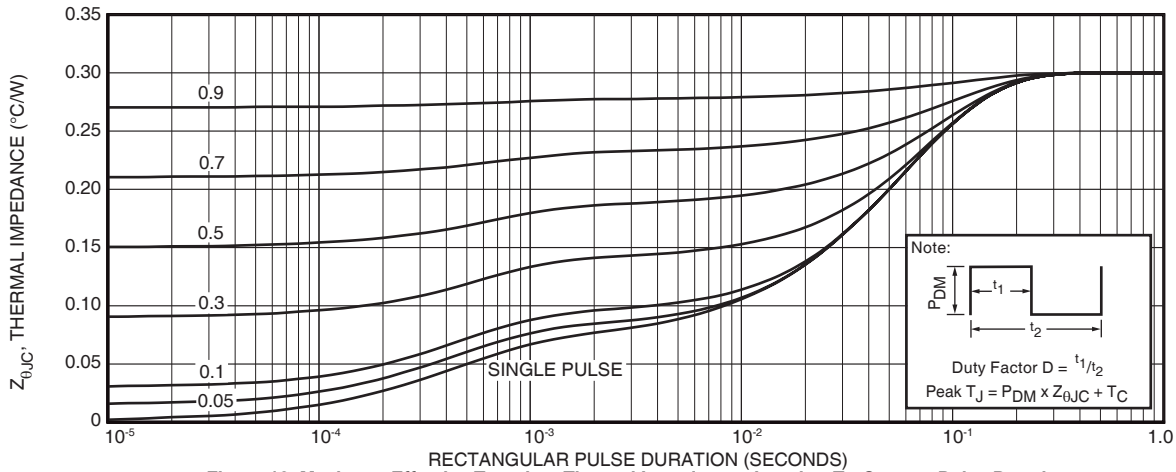
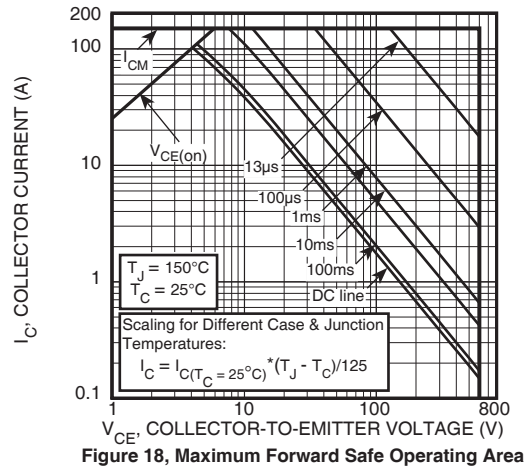
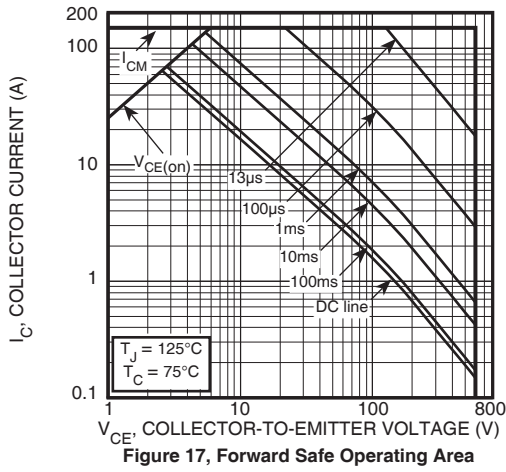


FIGURE 16, Switching Energy Losses vs Junction Temperature

TYPICAL PERFORMANCE CURVES

APT50GS60B_SRDQ2(G)



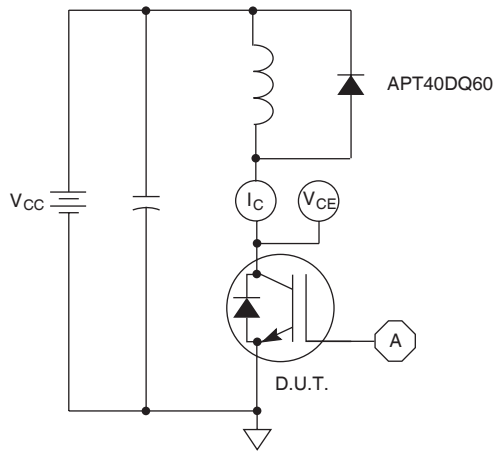


Figure 22, Inductive Switching Test Circuit

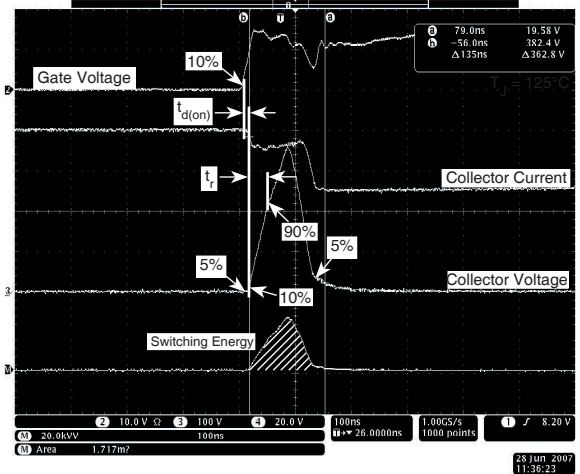


Figure 23, Turn-on Switching Waveforms and Definitions

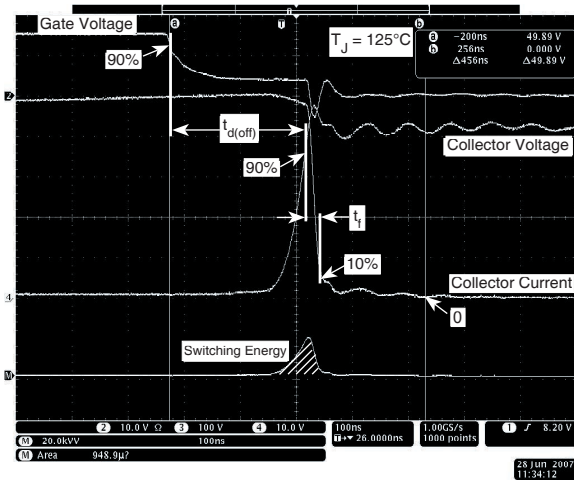


Figure 24, Turn-off Switching Waveforms and Definitions

FOOT NOTE:

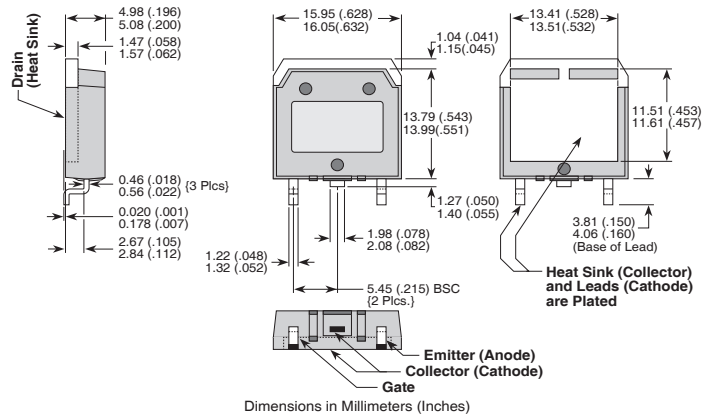
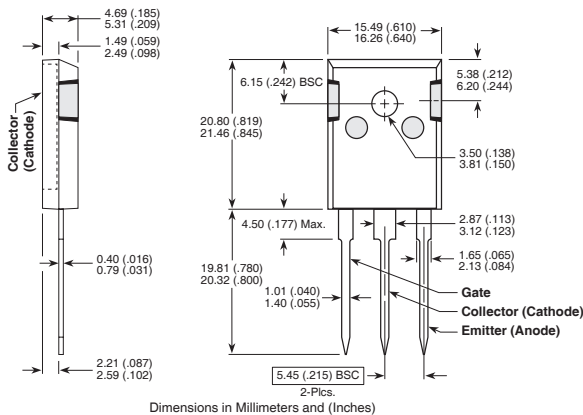
- ① Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- ② Starting at $T_J = 25^\circ\text{C}$, $L = 224\mu\text{H}$, $R_G = 25\Omega$, $I_C = 50\text{A}$
- ③ Short circuit time: $V_{GE} = 15\text{V}$, $V_{CC} \leq 600\text{V}$, $T_J \leq 150^\circ\text{C}$
- ④ Pulse test: Pulse width < $380\mu\text{s}$, duty cycle < 2%
- ⑤ $C_{o(cr)}$ is defined as a fixed capacitance with the same stored charge as C_{oes} with $V_{CE} = 67\%$ of $V_{(BR)CES}$.
- ⑥ $C_{o(er)}$ is defined as a fixed capacitance with the same stored energy as C_{oes} with $V_{CE} = 67\%$ of $V_{(BR)CES}$. To calculate $C_{o(er)}$ for any value of V_{CE} less than $V_{(BR)CES}$, use this equation: $C_{o(er)} = 5.57E-8/V_{DS}^2 + 7.15E-8/V_{DS} + 2.75E-10$.
- ⑦ R_G is external gate resistance, not including internal gate resistance or gate driver impedance (MIC4452).
- ⑧ E_{on1} is the inductive turn-on energy of the IGBT only, without the effect of a commutating diode reverse recovery current adding to the IGBT turn-on switching loss. It is measured by clamping the inductance with a Silicon Carbide Schottky diode.
- ⑨ E_{on2} is the inductive turn-on energy that includes a commutating diode reverse recovery current in the IGBT turn-on energy.
- ⑩ E_{off} is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1.

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

TO-247 Package Outline

D³ Pak Package Outline

ⓔ1 SAC: Tin, Silver, Copper



Microsemi's products are covered by one or more of U.S. patents 4,895,810 5,045,903 5,089,434 5,182,234 5,019,522 5,262,336 6,503,786 5,256,583 4,748,103 5,283,202 5,231,474 5,434,095 5,528,058 and foreign patents. US and Foreign patents pending. All Rights Reserved.

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